TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7SH08FE

2 Input AND Gate

Features

• Super high speed operation :tpD = 4.3 ns (typ.)

 $@V_{CC} = 5 \text{ V}$

• Low power dissipation : ICC = 2 μ A (Max.)

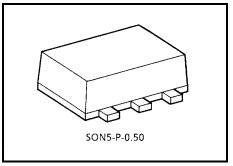
@ Ta = 25°C

• High noise immunity : $V_{NIH} = V_{NIH}$

= 28% VCC (Min.)

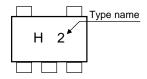
• 5.5V tolerant input.

• Wide operation voltage range : V_{CC} (opr) = $2 \sim 5.5 \text{ V}$

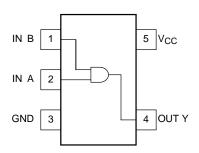


Weight: 0.003 g (typ.)

Marking



Pin Assignment (top view)



Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Supply voltage range	Vcc	-0.5~7	V
DC input voltage	V _{IN}	-0.5~7	V
DC output voltage	Vout	-0.5~V _{CC} + 0.5	V
Input diode current	lık	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V _{CC} /ground current	Icc	±50	mA
Power dissipation	P _D	150	mW
Storage temperature	T _{stg}	-65~150	°C

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Logic Diagram



Truth Table

Α	В	Υ
L	L	L
L	Н	L
Н	L	L
Н	Н	Н

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit	
Supply voltage	Vcc	2~5.5	V	
Input voltage	V _{IN}	0~5.5	V	
Output voltage	V _{OUT}	0~ V _{CC}	٧	
Operating temperature	T _{opr}	-40~85	°C	
Input rise and fall time	dt/dv	0~100 (V _{CC =} 3.3 V \pm 0.3 V)	ns/V	
input noe and fail tille	ui/uv	0~20 (V_{CC} = 5 V ± 0.5 V)		

Electrical Characteristics

DC Characteristics

Characteristics Symbol Test Circuit		Test	Test Condition			Ta = 25°C Ta = -40~85°C			0~85°C	Unit	
		lest Condition		V _{CC} (V)	Min	Тур.	Max	Min	Max	Unit	
High level innut				2.0	1.5	_	_	1.5	_	-	
High-level input voltage VIH —		_		3.0~5.5	V _{CC} × 0.7	_	_	V _{CC} × 0.7	_	V	
Low-level input					2.0	_	_	0.5	_	0.5	
voltage V _{IL} —		_		_	_	V _{CC} × 0.3	_	V _{CC} × 0.3	V		
	High-level VOH		$V_{IN} = V_{IH}$	I _{OH} = -50 μA	2.0	1.9	2.0	_	1.9	_	V
		_			3.0	2.9	3.0	_	2.9	_	
					4.5	4.4	4.5	_	4.4	_	
				$I_{OH} = -4 \text{ mA}$	3.0	2.58	_	_	2.48	_	
				$I_{OH} = -8 \text{ mA}$	4.5	3.94	_	_	3.80	_	
Low-level output voltage		V _{IN} = V _{IH} or V _{IL}	I _{OL} = 50 μA	2.0	_	0	0.1	_	0.1	٧	
				3.0	_	0	0.1	_	0.1		
	_			4.5		0	0.1	_	0.1		
			$I_{OL} = 4 \text{ mA}$	3.0	_	_	0.36	_	0.44		
			$I_{OL} = 8 \text{ mA}$	4.5		_	0.36	_	0.44		
Input leakage current	I _{IN}	_	$V_{IN} = 5.5 \text{ V or GND}$		0~5.5	_	_	±0.1	_	±1.0	μА
Quiescent supply current	Icc	_	V _{IN} = V _{CC} or GND		5.5			2.0	_	20.0	μА

AC Characteristics (input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = -40~85°C		Unit
			V _{CC} (V)	C _{L (} pF)	Min	Тур.	Max	Min	Max	
Propagation delay time	[†] PLH [†] PHL		3.3 ± 0.3	15	_	6.2	8.8	1.0	10.5	- ns
			3.3 ± 0.3	50	_	8.7	12.3	1.0	14.0	
		5.0 ± 0	5.0±0.5	15	_	4.3	5.9	1.0	7.0	
			5.0 ± 0.5	50	_	5.8	7.9	1.0	9.0	
Input capacitance	CIN				_	4	10	_	10	pF
Power dissipation capacitance	C _{PD}		(Note)		_	14		_	_	pF

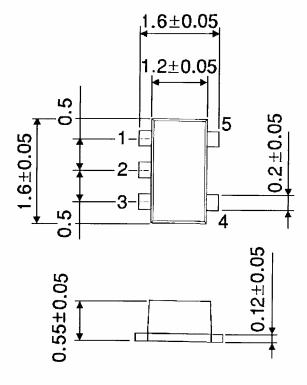
Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation.

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

Package Dimensions

SON5-P-0.50 Unit: mm



Weight: 0.003 g (typ.)

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